

Exams for group S15-402

Mon, 23 Dec	12:00 — 15:00	ATT	Sensors Based on Micro- and Nanotechnologies	Podlepetskiy B.I.	D-405	
Mon, 23 Dec	15:00 — 18:00	TEST	Life Safety	Mogilenets N.N.	B-213	
Tue, 24 Dec	09:00 — 12:00	TEST	Scientific Research Work	Shaltaeva Y.R.	dep.27	
Tue, 24 Dec	12:00 — 15:00	TEST	Elect	Microelectronic Radio Devices	Bocharov Y.I.	D-311
Tue, 24 Dec	12:00 — 15:00	TEST	Elect	Principles of functional and microwave microelectronics	Patrikeev L.N.	D-303
Tue, 24 Dec	15:00 — 18:00	TEST	Elect	Local Networks for Personal Computers	Lapshinskiy V.A.	B-216
Wed, 25 Dec	12:00 — 15:00	ATT	Principles of Optoelectronics	Voronov Y.A.	D-410	
Wed, 25 Dec	15:00 — 18:00	ATT	Software Support of Modern Microprocessors and Microcontrollers	Subgroup 1	Shaltaeva Y.R.	D-303
Wed, 25 Dec	15:00 — 18:00	ATT	Software Support of Modern Microprocessors and Microcontrollers	Subgroup 2	Bocharov Y.I.	D-311
Thu, 26 Dec	12:00 — 15:00	ATT	Reliability and Radiation Resistance of Integrated Circuits	Zebrev G.I.	D-311	
Thu, 26 Dec	15:00 — 18:00	TEST	Elect	Quantum Radiophysics	Larkin A.I.	K-1117
Fri, 27 Dec	09:00 — 12:00	TEST	Management and Marketing	Silenko A.N.	A-100	
Sat, 28 Dec	12:00 — 15:00	TEST	Information Measurement Systems	Belyakov V.V.	D-311	
Mon, 13 Jan	09:00 — 13:00	EXAM	Sensors Based on Micro- and Nanotechnologies	Podlepetskiy B.I.	K-415	
Fri, 17 Jan	09:00 — 13:00	EXAM	Software Support of Modern Microprocessors and Microcontrollers	Osipenko P.N.	D-303	
Tue, 21 Jan	09:00 — 13:00	EXAM	Principles of Optoelectronics	Voronov Y.A.	D-311	
Mon, 27 Jan	09:00 — 13:00	EXAM	Reliability and Radiation Resistance of Integrated Circuits	Zebrev G.I.	D-311	